

Search Notes

Application/Control No.

10/719,814

Examiner

Jared I. Rutz

Applicant(s)/Patent under
Reexamination

KAMEI ET AL.

Art Unit

2187

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search in EAST and PALM	5/24/2006	JIR
Fast and Focused search	5/24/2006	JIR
Text search in EAST; see search history	5/24/2006	JIR
Consulted Brian Peugh	5/16/2006	JIR
Consulted Christian Chace	5/23/2006	JIR